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PATENT USA.02.022

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Dennis V. Carmen Date: April 11, 2002

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of)	
STEWART et al	{	
Serial No. 10/091086	{	Group Art Unit: Unknown
Filed: March 5, 2002	{	Examiner: Unknown
ATTACHMENT OF SURFACE MOUNT DEVICES TO PRINTED CIRCUIT BOARDS USING A THERMPLASTIC ADHESIVE)))	April 11, 2002

ASSISTANT COMMISSIONER FOR PATENTS Washington, DC 20231

Sir:

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.56 AND 1.97

It is respectfully requested that the documents listed on the attached Form PTO-1449 be considered by the Patent and Trademark Office in the above-entitled application and made of record therein. Full text copies of the relevant documents are enclosed.

The Examiner is requested to indicate consideration of this art on the attached PTO-1449 (Modified) by initialing next to each item submitted by the applicant.

Respectfully submitted,

Dennis V. Carmen Registration No. 35, 007 (713) 241-3554

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FORM PTO-1449 (Modified for Citation of Foreign		ATTY. DOCKET NO.		SERIAL NO.			
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1. The attached cited information should not be construed as an admission that any of the above items are prior art

DATE CONSIDERED

EXAMINER

to the subject invention.

This is not a representation that a search has been made.

^{*}Date when provided in xx/yy/zz format represents MONTH/DAY/YEAR.

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